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(NASA-CR-141919) SKYIAB MISSIONS SL/1, 2, N75-28396
3, 4 PHOTOGRAPHIC PROCESSING CONTROL PLAN
(Technicolor Graphic Services, Inc.) 7 p HC
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SKYLAB MISSIONS SL/1,2,3,4

PHOTOGRAPHIC PROCESSING CONTROL PLAN

INTRODUCTION:

This document defines the control parameters to be used by the Photographic Technology Division for the processing of films flown on Skylab Missions SL/1, 2, 3, and 4. It defines the sensitometric exposure and processing conditions PTD plans to use, describes the procedures necessary for general film certification, and will serve as a vehicle for denoting and solving any problem areas or conflicts which may occur prior to the mission. This document will be updated whenever new information is obtained.

REFERENCES

- Technicolor Technical Note, TN 72-12, "Film Handling Procedures for Skylab S-056 Experiment", dated September 1972.
- Technicolor Technical Note, TN. 73-1, "Duplication Trial of SO-212 Film for Skylab S-056 Experiment", dated January 1973.
- 3. Technicolor Technical Note, TN 73-2, "Radiation Effects on Skylab Films, Interim Report", dated February 1973.
- 4. Technicolor Technical Report, TR 72-4, "Protective Overcoating of Films", dated June 1972.
- 5. NASA/PTD Document, JL12-202, "S-190 A and B, and S-191 Film Handling Procedures", dated November 1972, Revision A, dated December 1972.
- 6. Technicolor Technical Report, TR 73-1, "Evaluation of Anomalies Observed on Film from S-190A Flight System Calibration Tests", dated January 1973.
- 7. NASA/PTD Document, JL12-204, "S-056 Film Handling Procedures", dated March 1973.

LIST OF ABBREVIATIONS

American Standards Association ASA MTA Apollo Telescope Module Black and white Exterior Film -EK Type 2403 BE Black and white High Speed film -EK Type 3401 BH Black and white Very High Speed film -EK Type 2485 BV Black and White Low Speed Film -EK Type 3414 BW Color Interior Film -EK Type SO-168 (320 ASA) CI Color Low Light Film -EK Type SO-168 (160 ASA) CL Color Film -EK Type SO-242 CT Color Exterior Film -EK Type SO-368 CX cm centimeter relation of density to logarithm of exposure D-log E °F. degrees Fahrenheit degrees Kelvin °K. feet per minute fpm inch (es) in. Color Infrared Film -EK Type 3443 IR logarithm of exposure log E Motion Picture Laboratory MPL millimeter mm National Aeronautics and Space Administration NASA ND neutral density nanometer nm the negative logarithm of the hydrogen ion conpН centration expressed in moles per liter PI Principal Investigator(s) PPL Precision Processing Laboratory **PSO** Photo Science Office PTD Photographic Technology Division Quality Control QC RH Relative humidity Still Laboratory SL Skylab/one, two, three, or four SL/--

Black and White ultraviolet sensitive film -EK Type

number of tanks

103a0

Ultraviolet

To Be Determined

T

TBD

ÜA

UV

BTTM		M.TT.R.	EMIT,S TON	STZE	PROCESSOR	CHEMISTRY	FILTRATION	EXPOSURE	NOTES	1
ATION			NUMBER					TIME (sec)		1
CI S0-16	so-16	ထွ	012-01	16mm	RAM	ME-4	5500°K	1/100	320 ASA	
S0-168	so-16	ω	. 12-1	35mm	Houston	ME-4	5500°K	1/100	320 ASA	
CL S0-1(so-1(ထွ	12-1	3.5mm	Houston	ME-4	5500°K	1/100	160 ASA (T025)	(T025)
SO-3(so-3	တ္ထ	018-326	1.6mm	Hi-Speed	ME-2A	5500°K	1/50		
CX S0-3(SO-3(8	18-811	35mm	Hi-Speed	ME-2A	5500°K	1/50		
CX S0-3	S0-3	89	18-81	7 Orum	Hi-Speed	ME-2A	5500°K	1/50		
so-356 so-3	SO-3	56	16-4	7 Orum	Houston	ME-4	5500°K	1/5		
CT S0-2	S0-2	42	36-12	5 in.	VMT 1811	EA-5	5500°K	1/5		
	2443		116-20	7 Omm	VMT 1811	EA-5	5500°K+Wr12	1/50		
	3443		10-600	1.6mm	RAM	ME-4	2850°K+ .3ND	1/100		
IR 344	3443	_	11	5 in.	VMT 1811	EA-5	5500°K + Wrl2	1/50		
so-022 so-(SO-0	322	1-1	7 Omm.	Fultron	618-XW	5500°K + Wr25	1/5		
	SO	212	4-1	35mm	Hi-Speed	D-19	5500°K	1/50		
	2403		52-20	35mm	Hi-Speed	D-19	5500°K	1/100		•
2424 2424	2424		43-1	7 Omm	Hi-Speed	D-19	5500°K + 89B	1/50		
	248		108-05	16mm	Hi-Speed	D-19	5500°K +1.0 ND	1/100		
BV 248	248		108-5	3 5mm	Hi-Speed	D-19	5500°K + 1.0 ND	1/100	T025	
BV 2485	248		108-5	35mm	Hi-Speed	D-19	5500°K + 1.0ND	1/100	. 8063	<i>i</i>
2474	2474		149-02	16mm	Houston 16	D-19	5500°K	1/100		
з401	340]		384-04	16mm	Houston 16	D-19	5500°K	1/50		
BW 3414	3414		21-8/2	5 in.	Fultron	MX-819	5500°K + Wrl2	1/10		
UA 103a0	103	Q	162794	16mm	Hi-Speed	D-19B	3000°K +2650A Inconel Tablet	8		

2.0 FILM CERTIFICATION PROCEDURES

- 2.1 The sensitometric characteristics of each film type and emulsion are established by exposure on the I-B sensitometer and are controlled by processing as determined for the respective films. The condition for sensitometric exposure of each film type is specified as to:
 - a. Color temperature
 - b. Filtration, as prescribed by the film application.
 - c. Exposure needed to place the resulting density exposure relationship in a desired position on the D-log E curve.
- 2.2 After the processing machine has met Quality Control chemical and sensitometric standards, five sensitometric strips of the film to be certified are processed. The densitometric values of these processed exposure wedges are averaged and the result is plotted to represent the certification data for subsequent sensitometric control for that particular film type. In general, a number of curves using various time/temperature/chemistry configurations are obtained using the above described method. The Photo Science Office reviews these curves with the Principal Investigator and jointly arrive at the optimum D-log E curve to satisfy the requirements of the experiment.
- One roll of each film type is visually inspected in white light to check for dirt, scratches, coating imperfections, etc.
- 2.4 After the inspection is completed, the inspected roll is visibly marked and retained intact until after processing of the mission film.
- 2.5 Additional tests are conducted by the Photo Science
 Office as required by the Principal Investigator. These
 may include tests to determine latent image and radiation
 effects, resolution, granularity, etc.

3.0 DISCUSSION

3.1 PCD-H, SO-242-36-12, 5 inch

The control curve supplied is for a different emulsion batch than the one designated for flight. Tests are presently being conducted on the flight emulsion. A new D-log E curve will be supplied upon completion of the tests.

3.2 PCD-M, SO-212-4-1, 35mm

Tests are still being conducted by the PTD in conjunction with the PI. A final curve will be supplied upon completion of all testing.

3.3 PCD-N, 2403-52-20, 35mm; PCD-Q, 2485-108-5, 35mm

The curves included in this document have not yet been approved by the PI. Resolution tests are being conducted to assist in the determination of the final curve.

3.4 PCD-V, 103a0 - 162794, 16mm

Testing in D-19 and D-19B chemistries has been completed. The final D-log E curve will be supplied after approval by the PI.